
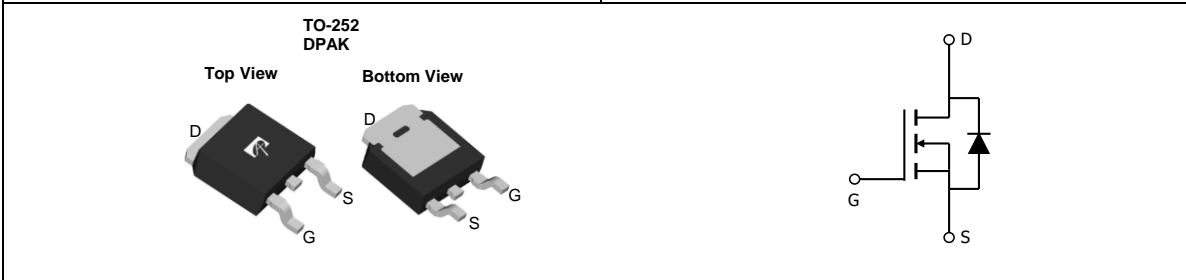


<p>General Description</p> <ul style="list-style-type: none"> Excellent $R_{DS(ON)}$*A Optimized switching parameters for better EMI performance Enhanced body diode for robustness and fast reverse recovery RoHS 2.0 and Halogen-Free Compliant <p>Applications</p> <ul style="list-style-type: none"> SMPS Hard-switching PFC, Resonant PFC/LLC/ZVS FB topologies Telecom, Server, ATX and Solar Inverter, Motor Drive 	<p>Product Summary</p> <table style="width: 100%; border: none;"> <tr> <td style="padding: 2px;">$V_{DS} @ T_{j,max}$</td> <td style="padding: 2px; text-align: right;">700V</td> </tr> <tr> <td style="padding: 2px;">I_{DM}</td> <td style="padding: 2px; text-align: right;">45A</td> </tr> <tr> <td style="padding: 2px;">$R_{DS(ON),max}$</td> <td style="padding: 2px; text-align: right;">< 0.21Ω</td> </tr> <tr> <td style="padding: 2px;">$Q_{g,typ}$</td> <td style="padding: 2px; text-align: right;">22nC</td> </tr> <tr> <td style="padding: 2px;">$E_{oss} @ 400V$</td> <td style="padding: 2px; text-align: right;">4.1μJ</td> </tr> </table> <p>100% UIS Tested 100% R_g Tested</p> <div style="text-align: right;">  </div>	$V_{DS} @ T_{j,max}$	700V	I_{DM}	45A	$R_{DS(ON),max}$	< 0.21 Ω	$Q_{g,typ}$	22nC	$E_{oss} @ 400V$	4.1 μ J
$V_{DS} @ T_{j,max}$	700V										
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Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOD210V60E	TO-252	Tape & Reel	2500

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	600	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	A
		$T_C=100^\circ\text{C}$	
Pulsed Drain Current ^C	I_{DM}	45	
Single pulsed avalanche energy ^H	E_{AS}	188	mJ
MOSFET dv/dt ruggedness, $V_{DS}=0$ to 400V	dv/dt	100	V/ns
Diode reverse recovery $V_{DS}=0$ to 400V, $I_F=20\text{A}$, $T_j=25^\circ\text{C}$	dv/dt	50	
	di/dt	500	A/us
Power Dissipation ^B	P_D	$T_C=25^\circ\text{C}$	W
		Derate above 25 $^\circ\text{C}$	1.0
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ\text{C}$
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typical	Maximum	Units
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	40	50	$^\circ\text{C/W}$
Maximum Case-to-sink ^A	$R_{\theta CS}$	-	0.5	$^\circ\text{C/W}$
Maximum Junction-to-Case ^{D,F}	$R_{\theta JC}$	0.65	1.0	$^\circ\text{C/W}$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =25°C	600			V
		I _D =10mA, V _{GS} =0V, T _J =150°C		700		
BV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D =10mA, V _{GS} =0V		0.57		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =600V, V _{GS} =0V			10	μA
		V _{DS} =480V, T _J =125°C		6.2		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	3.2	3.9	4.6	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =2.3A		0.19	0.21	Ω
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =2.3A		6		S
V _{SD}	Diode Forward Voltage	I _S =2.3A, V _{GS} =0V		0.8	1.2	V
I _S	Maximum Body-Diode Continuous Current				15	A
I _{SM}	Maximum Body-Diode Pulsed Current ^C				45	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		1560		pF
C _{oss}	Output Capacitance				60	
C _{o(er)}	Effective output capacitance, energy related ^I	V _{GS} =0V, V _{DS} =0 to 480V, f=1MHz		45		pF
C _{o(tr)}	Effective output capacitance, time related ^J				240	
C _{rss}	Reverse Transfer Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		7.5		pF
R _g	Gate resistance	f=1MHz		2		Ω
SWITCHING PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =480V, I _D =7.5A		22		nC
Q _{gs}	Gate Source Charge			8		nC
Q _{gd}	Gate Drain Charge			6		nC
T _{d(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =400V, I _D =7.5A, R _G =5Ω		24		ns
T _r	Turn-On Rise Time			18		ns
T _{d(off)}	Turn-Off DelayTime			38		ns
T _f	Turn-Off Fall Time			4		ns
T _{rr}	Body Diode Reverse Recovery Time				190	
I _{rm}	Peak Reverse Recovery Current	I _F =7.5A, di/dt=100A/μs, V _{DS} =400V		17		A
Q _{rr}	Body Diode Reverse Recovery Charge			1.6		μC

- A. The value of R_{θJA} is measured with the device in a still air environment with T_A=25° C.
- B. The power dissipation P_D is based on T_{J(MAX)}=150° C in a TO252 package, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C.
- D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C.
- G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.
- H. L=60mH, I_{AS}=2.5A, R_G=25Ω, Starting T_J=25° C.
- I. C_{o(er)} is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.
- J. C_{o(tr)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

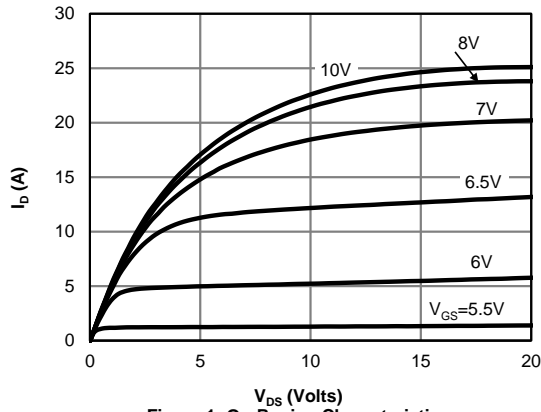


Figure 1: On-Region Characteristics

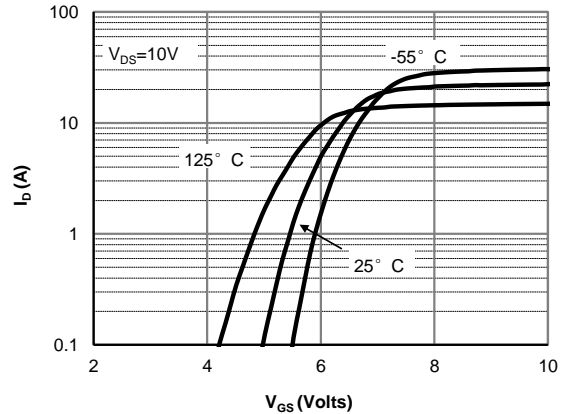


Figure 2: Transfer Characteristics

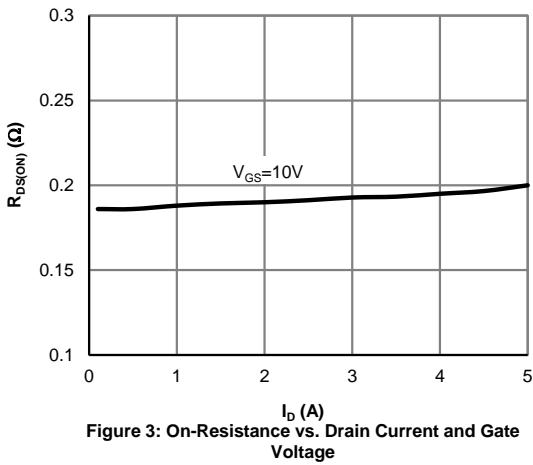


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

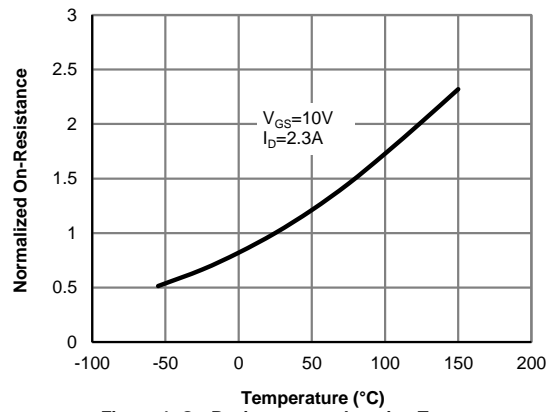


Figure 4: On-Resistance vs. Junction Temperature

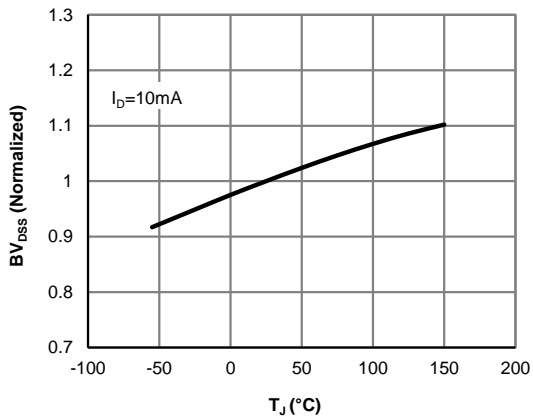


Figure 5: Break Down vs. Junction Temperature

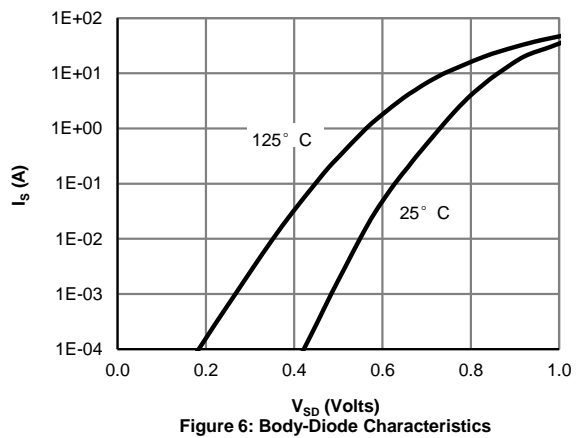


Figure 6: Body-Diode Characteristics

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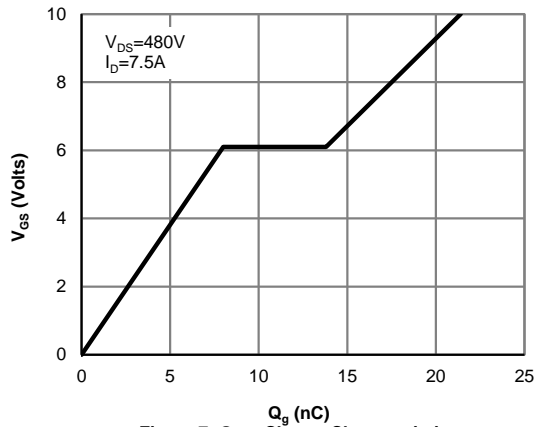


Figure 7: Gate-Charge Characteristics

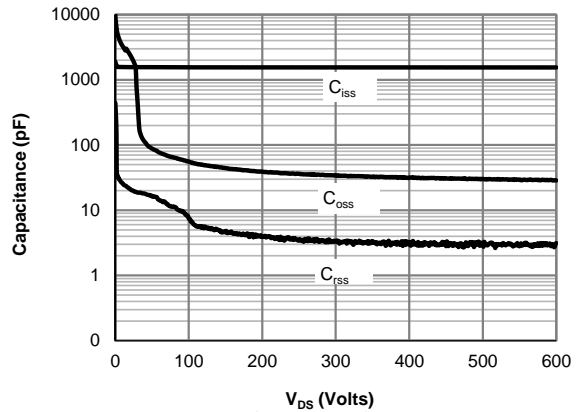


Figure 8: Capacitance Characteristics

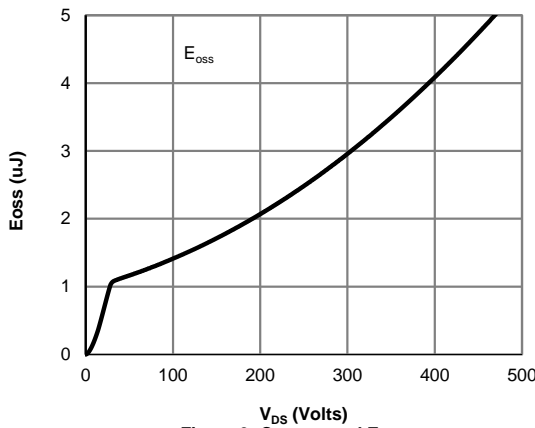


Figure 9: Coss stored Energy

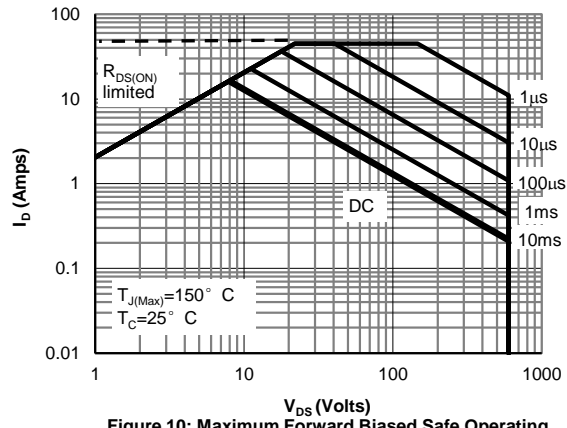


Figure 10: Maximum Forward Biased Safe Operating Area (Note F)

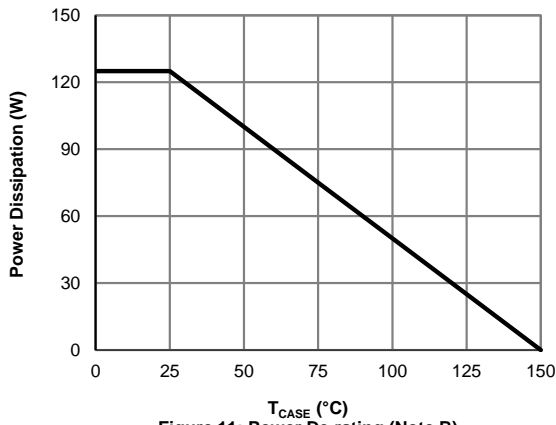


Figure 11: Power De-rating (Note B)

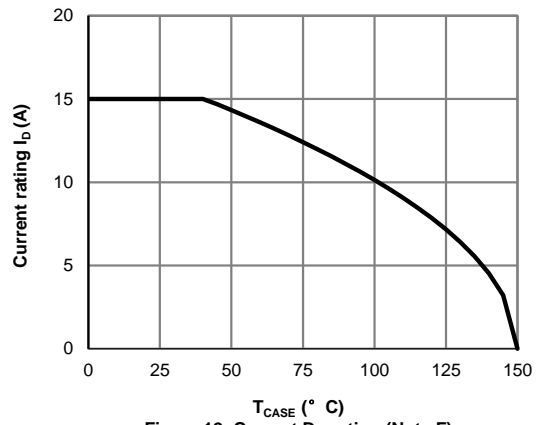


Figure 12: Current De-rating (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

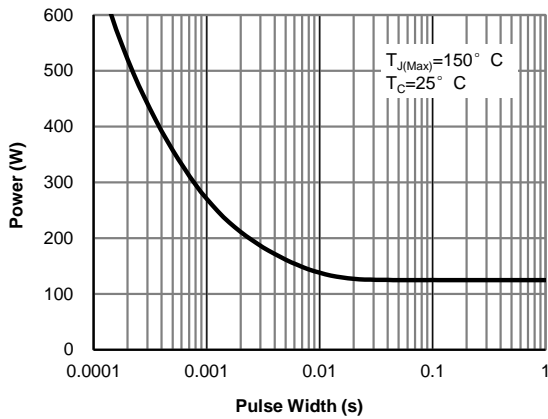


Figure 13: Single Pulse Power Rating Junction-to-Case (Note F)

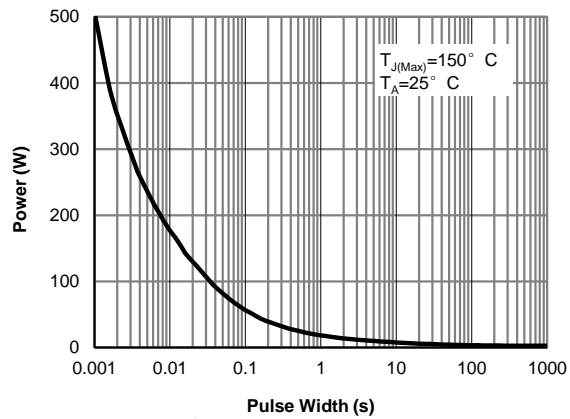


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note G)

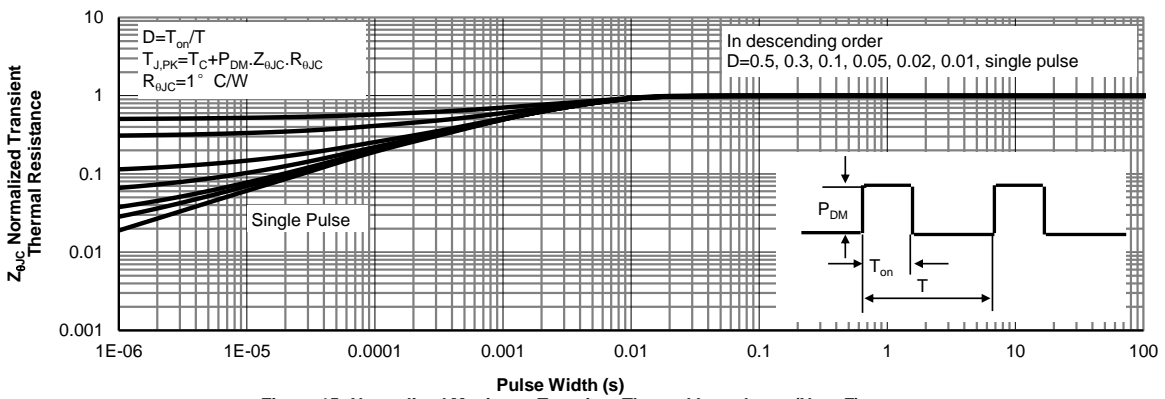


Figure 15: Normalized Maximum Transient Thermal Impedance (Note F)

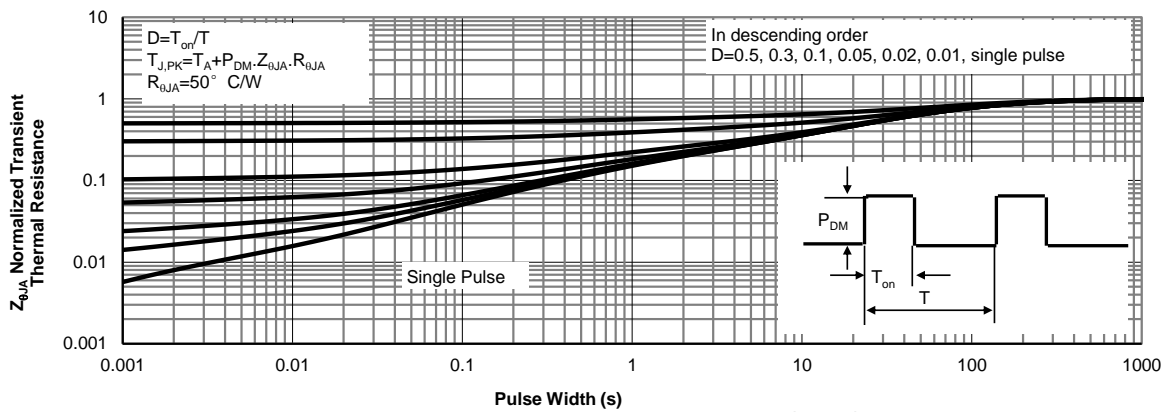
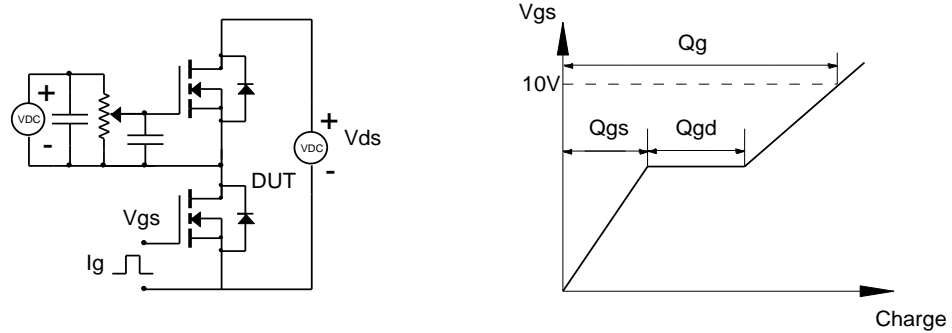
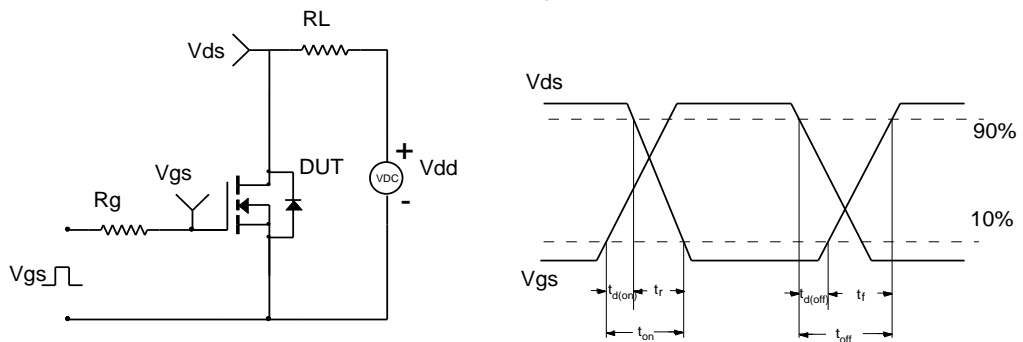


Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

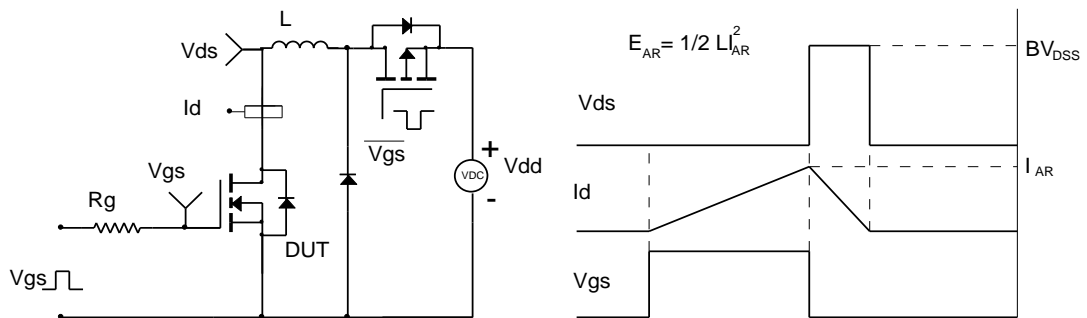
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

